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Form PTO-1449 US Dept. of Commerce (REV. 1/06) PATENT & TRADEMARK OFFICE			ATTY DOCKET NO. 129122			APPLICATION NO. New U.S. Patent Application					
INFORMATION DISCLOSURE STATEMENT						Applicatio					
(Use several sheets if necessary)			APPLICANTS Yukihiro NAKASAKA								
				FILING DATE August 18, 2006							
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Examiner Initials	Cite No.	Document Number	Date		Name						
	1	2003/0047166 A1	3/13/2003		Hess et al.						
FOREIGN PATENT DOCUMENTS											
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/S.V./	2	JP A 4-311631	11/4/1992		Japan		x				
/S.V./	3	JP A 4-299084	10/22/1992		Japan		х				
/S.V./	4	JP A 2004-176689	6/24/2004		Japan		х	х			
/S.V./	5	JP A 5-156979	6/22/1993		Japan		x	x			
/S.V./	6	JP A 9-032710	2/4/1997		Japan		х	х			
/S.V./	7	JP A 2003-522878	7/29/2003		Japan			x			
/S.V./	8	JP A 2004-138036	5/13/200	)4	Japan		x	x			
/S.V./	9	WO 01/59282 A1	8/16/200	)1	WIPO		х				
/S.V./	10	WO 2005/008052 A1	1/27/200	)5	WIPO		x				
/S.V./	11	JP B 2831483	9/25/19	99	Japan			x			
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